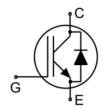


Main Product Characteristics:

Vces	700V			
lc	50A			
V _{CE(sat)}	1.75V			





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Schematic Diagram

Features and Benefits:

- Trench FS technology offering
- High speed switching
- Low gate charge and V_{CE(sat)}
- High ruggedness, temperature stable behavior
- Maximum junction temperature 175°C



Applications:

- Solar Inverters
- Uninterruptible power supplies
- Motor drives
- Air condition

Absolute Max Rating:

Symbol	Parameter	Value	Units		
V _{CES}	Collector-Emitter Voltage	700	V		
V _{GES}	Gate- Emitter Voltage	±30	V		
	Collector Current	100			
Ic	Collector Current @T _C = 100 °C	50	_		
I _{Cpuls}	Pulsed Collector Current, tp limited by Tjmax	200	Α		
-	Turn off safe operating area, V _{CE} =650V, T _J =175°C	area, V _{CE} =650V, T _J =175°C 200			
1-	Diode Continuous Forward Current @Tc = 25 °C	100			
lF	Diode Continuous Forward Current @Tc = 100 °C	50	Α		
Ігм	Diode Maximum Forward Current	200			
D	Power Dissipation @ T _C = 25°C	296	W		
P _D	Power Dissipation @ T _C = 100°C	148	W		
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to +175	°C		
T∟	Maximum Temperature for Soldering	260	°C		



Thermal Resistance

Symbol	Characterizes	Тур.	Max.	Units
Rejc	Thermal Resistance,Junction-to-case for IGBT	_	0.5	°C/W
NejC	Thermal Resistance, Junction-to-case for Diode	_	0.63	°C/W
R _{θJA}	R _{eJA} Thermal Resistance, Junction-to-ambient		40	°C/W

Electrical Characteristics @T_A=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions	
V(BR)CES	Collector-Emitter Breakdown Voltage	700	_	_	V	Vge=0V,Ice=1mA	
	Collector-Emitter Saturation Voltage		1.75	1.9	٧	Ic=50A ,VGE=15V	
VCE(sat)		_				@T _J =25°C	
V _{GE(th)}	Gate Threshold Voltage	4	_	6	V	Ic=250µA,Vce=Vge	
Ices	Collector-Emitter Leakage Current	_	_	1	μΑ	Vge =0V,Vce=700V	
1	Cata to Freitter Deverse Leakers	_	_	100	^	Vge=25V,Vce=0V	
Iges	Gate to Emitter Reverse Leakage	_	_	-100	nA	Vge=-25V,Vce =0V	
Cies	Input capacitance	_	2750	_		V _{GS} = 0V	
Coes	Output capacitance	_	120	_	pF	V _{DS} = 25V	
Cres	Reverse transfer capacitance	_	68	_		f = 1MHz	
t _{d(on)}	Turn-on delay time	_	29	_			
t _r	Rise time	_	51	_]	$Vcc=400V, Ic=50A, \ VgE=0/15V, Rg=10\Omega, \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \$	
t _{d(off)}	Turn-Off delay time	_	150	_	ns		
t _f	Fall time	_	61	_			
Eon	Turn-On Switching Loss	_	1.18	_		N 400VI 50A	
Eoff	Turn-Off Switching Loss	_	0.79	_	mJ	Vcc=400V,Ic=50A,	
Ets	Total Switching Loss	_	1.97	_		$V_{GE=0/15V}$, $R_{g=10\Omega}$,	
Qg	Total Gate Charge	_	155	_		Vcc=480V, Ic=50A, VgE=15V	
Qge	Gate to Emitter Charge	_	35	_	nC		
Qgc	Gate to Collector Charge	_	65	_			
	Short circuit collector current					\\ 15\\\\ <100\\	
Ic(sc)	Max.1000 short circuits	_	340	_	A	V _{GE} =15V,V _{CC} ≤400V,	
	Time between short circuits: ≥1.0s					t _{sc} ≤5µs	

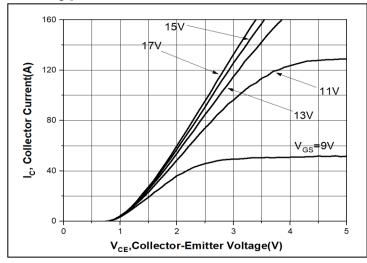
Electrical Characteristics of the Diode@T_A=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Vғм	Diode Forward Voltage	_	1.77	2.5	V	I==50A
t _{rr}	Reverse Recovery Time	_	83	_	ns	
Q _{rr}	Reverse Recovery Charge	_	0.79	_	μC	$T_J = 25$ °C, $I_F = 50$ A, $di/dt =$
IRRM	Diode Peak Reverse Recovery		40.0	_	А	200A/µs
	Current	_	18.2			





Typical Electrical and Thermal Characteristics



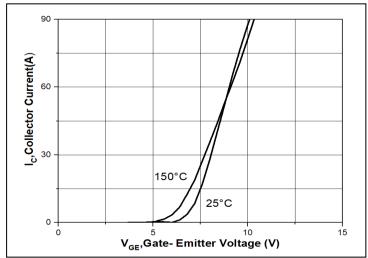
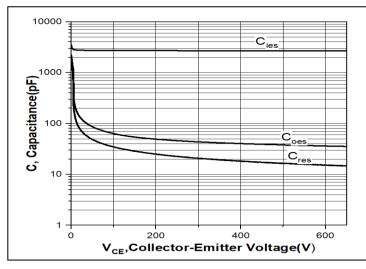


Figure 1. Typical Output Characteristics

Figure 2. Typical Transfer Characteristics



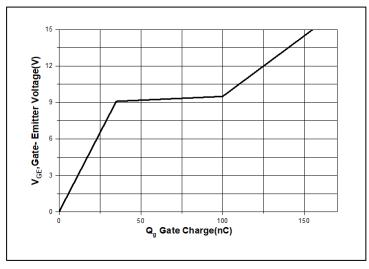


Figure 3. Typical Capacitance

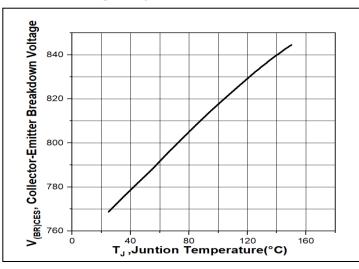


Figure 4. Typical Gate Charge

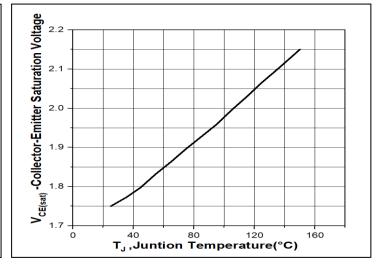
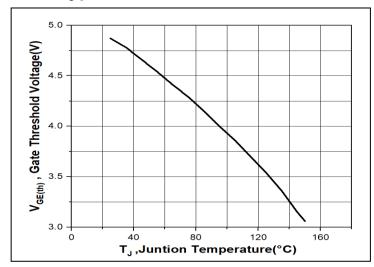


Figure 5. Collector-Emitter Breakdown Voltage vs. Temperature

Figure 6. Collector-Emitter Saturation Voltage vs. Temperature



Typical Electrical and Thermal Characteristics



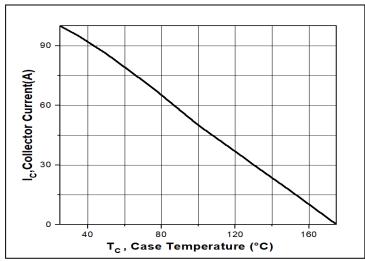


Figure7.Gate Threshold Voltage vs. Temperature

Figure8.Collector Current vs. Temperature

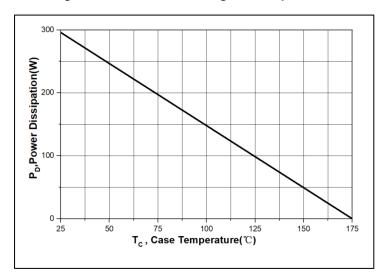


Figure 9. Power Dissipation vs. Case Temperature

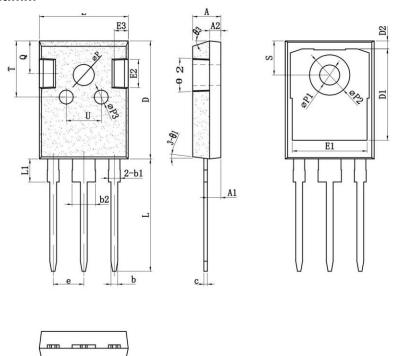




Mechanical Data:

Option1:

Unit:mm

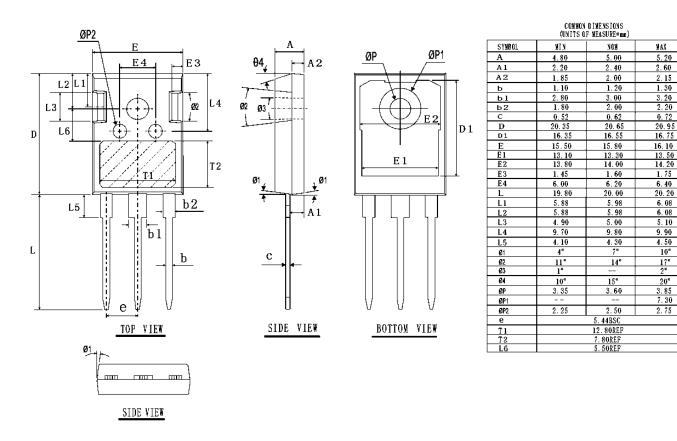


arnmor.	mm					
SYMBOL	MIN	NOM	MAX			
* A	4. 90	5. 00	5. 10			
* A1	2. 31	2. 41	2. 51			
A2	1.90	2. 00	2. 10			
* b	1. 15	1. 20	1. 25			
* b1	1. 95	2. 10	2. 25			
* b2	2. 95	3. 10	3. 25			
* C	0. 55	0. 60	0. 65			
* D	20. 90	21.00	21. 10			
D1	16. 35	16. 55	16. 75			
D2	1.05	1. 20	1. 35			
* E	15. 70	15. 80	15. 90			
E1	13. 10	13. 25	13. 40			
E2	4. 90	5. 00	5. 10			
ЕЗ	2. 40	2. 50	2. 60			
*e	5. 40	5. 44	5. 48			
* L	19. 80	19. 80 19. 98				
* L1			4. 30			
* ΦP	3. 60	3. 60 3. 70				
* ФР1	3. 45	3. 55	3. 65			
ФР2	7. 03	7. 18	7. 33			
ФРЗ	2. 40	2. 50	2. 60			
Q	5. 60	5. 80	6.00			
* S	6. 05	6. 15	6. 25			
Т	9. 80	10.00	10. 20			
U	6. 00	6. 20	6. 40			
91	5°	7°	9°			
θ2	1°	3°	5°			
93	13°	15°	17°			





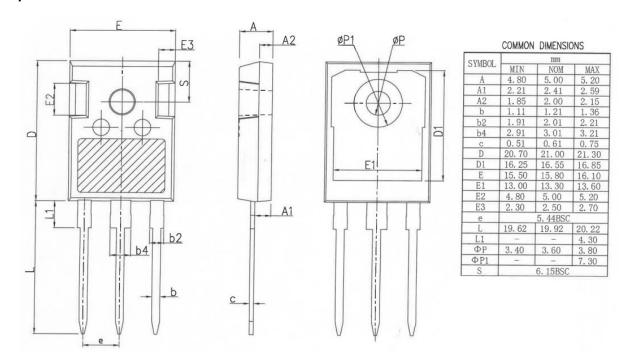
Option2:







Option3:







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